

Search Notes

Application/Control No.

10/691,452

Examiner

Jeffrey T. Barton

Applicant(s)/Patent under
Reexamination

KARDAUSKAS ET AL.

Art Unit

1795

SEARCHED

Class	Subclass	Date	Examiner
136	246	3/8/2007	ADF
Updated	previous	6/5/2008	JTB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See EAST search history	3/8/2007	ADF
Inventor search	3/8/2007	ADF
Consulted with Jeffrey Barton and Nam Nguyen	3/9/2007	ADF
Google scholar internet database search for keywords	3/9/2007	ADF
Google scholar search on "diffraction" ,"grating", "order".	6/5/2008	JTB